

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Kazuhiro ATSUMI et al.	)	Confirmation No.: Unassigned
Application No.: 10/585,451	)	Group Art Unit: Unassigned
Filed: July 7, 2006	)	Examiner: Unassigned
For: LASER PROCESSING METHOD AND DEVICE	) ) )	
Commissioner for Patents U.S. Patent and Trademark Office Alexandria, VA 22314		
Sir:		

## SUBMISSION OF INTERNATIONAL PRELIMINARY EXAMINATION REPORT

Applicants bring to the attention of the Examiner the attached document.

Attached is an English-language translation of an International Preliminary Examination Report ("IPER") dated August 31, 2006 that issued in a related PCT/JP2004/018591 application. Applicants respectfully request that the Examiner consider the IPER as it relates to the above-identified application.

While the IPER cites to three particular documents, these documents are not attached hereto because they were previously filed in an Information Disclosure Statement in this application on July 7, 2006.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that the listed document is material or constitute "prior art."

If it should be determined that the listed document does not constitute "prior art" under United

ATTORNEY DOCKET NO.: 46884-5497

Application No.: 10/585,451

Page 2

States law, Applicants reserve the right to present to the office the relevant facts and law

regarding the appropriate status of such document.

Applicants further reserve the right to take appropriate action to establish the patentability

of the disclosed invention over the listed documents, should one or more of the documents be

applied against the claims of the present application.

**EXCEPT** for issue fees payable under 37 C.F.R. § 1.18, the Commissioner is hereby

authorized by this paper to charge any additional fees during the entire pendency of this

application including fees due under 37 C.F.R. § 1.16 and 1.17 which may be required, including

any required extension of time fees, or credit any overpayment to Deposit Account No. 50-0573.

This paragraph is intended to be a **CONSTRUCTIVE PETITION FOR EXTENSION OF** 

TIME in accordance with 37 C.F.R. § 1.136(a)(3).

Respectfully submitted,

DRINKER, BIDDLE & REATH LLP

Dated: February 2, 2007

By:

Peter J. Sistare

Registration No. 48,183

Customer No. 055694 DRINKER, BIDDLE & REATH LLP

1500 K Street, N.W., Suite 1100 Washington, D.C. 20005-1209

Tel: (202) 842-8800 Fax: (202) 842-8465



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re A	pplicati	on of: Kazuhiro ATSUMI et al.	)	
Applic	ation N	o.: 10/585,451	)	Group Art Unit: Unassigned
Filed:	July 7,	2006	)	Examiner: Unassigned
For:	LASEI DEVIO	R PROCESSING METHOD AND CE	)	
U.S. P Custo	atent an mer Wi	for Patents d Trademark Office ndow Mail Stop: Amendment A 22314	£	AF Issue Fee
Sir:		NATIONAL TRANSPORT OF THE		
		INFORMATION DISCLOSE	<u>JRE</u>	E STATEMENT (IDS)
the une	to the a dersigne on the	ttention of the Examiner the docume ed's knowledge, this IDS is being file	ents ed be irst	.F.R. §§ 1.56 and 1.97(b), Applicant listed on the attached PTO Form 1449. To efore the mailing date of a first Office Office Action on the merits after filing an lication filing date.
is bein mailin	attention g filed a g date o	n of the Examiner the documents list	ed c ut, t	F.R. §§ 1.56 and 1.97(c), Applicant brings on the attached PTO Form 1449. This IDS to the undersigned's knowledge, before the wance, or another action that closes
		The fee of \$180.00 set forth in § 1.1	.7(p	) is included herein; or
			fore	ormation contained in this IDS was first eign patent office in a counterpart foreign prior to the filing of this IDS.
	to the a	ttention of the Examiner the docume	nts	F.R. §§ 1.56 and 1.97(d), Applicant listed on the attached PTO Form 1449. 7(c) but before payment of the issue fee.
		The fee of \$180.00 set forth in § 1.1	7(p	) is included herein; and
			fore	ormation contained in this IDS was first eign patent office in a counterpart foreign prior to the filing of this IDS.

Attorney Docket No. 46884-5497 Application Number: 10/585,451

Page 2

Under 37 C.F.R. § 1.97(i): Pursuant to 37 C.F.R. §§ 1.56 and 1.97(i), Applicant brings
to the attention of the Examiner the documents listed on the attached PTO Form 1449. This IDS
is being filed after the events recited in § 1.97(d). Applicant requests that the IDS be placed in
the file.
A search report or other listing of documents from a counterpart, related, or other application dated and having documents cited thereon is attached for the
Examiner's consideration. Any of these documents not previously cited, and any additional
documents are listed on the PTO Form 1449.

Applicant respectfully requests that the Examiner consider the listed documents and evidence that consideration by making appropriate notations on the attached form. As for any document listed on the accompanying PTO-1449 that is in a language other than English, relevance can be understood from an enclosed English abstract or at least partial translation or from mention in the specification or in a search report for a corresponding application. Furthermore, Japanese Patent Publication Kou-shou 46-24989 was cited in a Notice of Refusal issued on November 2, 2004, in the opposition stage of a related Japanese patent. The Japanese Appeal Examiner asserted that: "This document discloses a method of separating a semiconductor substrate made of silicon or germanium and on which many electronic circuits and device are formed, by thermal impact caused by a laser irradiation."

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that any of the listed documents are material or constitute "prior art." If it should be determined that any of the listed documents do not constitute "prior art" under United States law, Applicant reserve the right to present to the Office the relevant facts and law regarding the appropriate status of such documents.

Applicant further reserves the right to take appropriate action to establish the patentability of the disclosed invention over the listed documents, should any of the documents be applied against the claims of the present application.

Except for issue fees payable under 37 C.F.R. § 1.18, the Commissioner is hereby authorized by this paper to charge any additional fees during the entire pendency of this Application, including fees due under 37 C.F.R. § 1.16 and 1.17 which may be required and including any required extension of time fees, or credit any overpayment to Deposit Account No. 50-0573. This paragraph is intended to be a CONSTRUCTIVE PETITION FOR EXTENSION OF TIME in accordance with 37 C.F.R. § 1.136(a)(3).

Respectfully submitted,

DRINKER, BIDDLE & REATH LLP

Dated: February 2, 2007

Peter J. Sistare

Registration No. 48,183

CUSTOMER NO. 055694 DRINKER, BIDDLE & REATH LLP

1500 K Street, N.W., Suite 1100 Washington, D.C. 20005-1209

Tel: 202.842.8800; Fax: 202.842.8465

DC\591355\1

Attorney Docket No. Application No.: RMATION DISCLOSURE CITATION 46884-5497 10/585,451 (Use several sheets if necessary) Applicant(s): Page 1 of 2 Kazuhiro ATSUMI et al. Page 1 of 1 PTO Form 1449 Filing Date: Group Art Unit: July 7, 2006 U.S. PUBLICATION DOCUMENTS \*Examiner Document Sub Initial Number Date Name Class Class Filing Date 4,562,333 Dec. 31, 1985 Taub et al. 5,254,833 Oct. 19, 1993 Okiyama 5,543,365 Aug. 6, 1996 Wills et al. 5,622,540 Apr. 22, 1997 Stevens 5,637,244 Jun. 10, 1997 Erokhin 5,776,220 Jul. 7, 1998 Allaire et al. 5,826,772 Oct. 27, 1998 Ariglio et al. 6,211,488 Apr. 3, 2001 Hoekstra et al. 6,252,197 Jun. 26, 2001 Hoekstra et al. -6,257,224 Jul. 10, 2001 Yoshino et al. 6,259,058 Jul. 10, 2001 Hoekstra 6,322,958 Nov. 27, 2001 Havashi 6,420,678 Jul. 16, 2002 Hoekstra Hoekstra et al. 6,489,588 Dec. 3, 2002 US2002/0006765 Jan. 17, 2002 Michel et al. US2003/0024909 Feb. 6, 2003 Hoekstra et al. -

FOREIGN PATENT DOCUMENTS

May 2, 2000

Jan. 1, 2001

Jan. 1, 2004

July 6, 2006

 Document	Document Sub Translati					tion
 Number	Date	Country	Class	Class	YES	NO
JP 04-111800	Apr. 13, 1992	Japan			X	
JP 07-040336	Feb. 10, 1995	Japan			X (abstract)	
JP 10-163780	Jun. 19, 1998	Japan			X (abstract)	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner

6,055,829

6,175,096 B1

US2004/0002199

US2006/0144828

Date Considered

Witzmann et al.

Fukuyo et al.

Fukumitsu et al.

\_

Nielsen

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

## Attorney Docket No. Application No.: INFORMATION DISCLOSURE CITATION 46884-5497 10/585,451 (Use several sheets if necessary) Applicant(s): Page 2 of 2 Kazuhiro ATSUMI et al. Page 1 of 1 PTO Form 1449 Filing Date: Group Art Unit: July 7, 2006 FOREIGN PATENT DOCUMENTS Document Sub Translation Number Date Country Class Class YES NO JP 11-138896 May 25, 1999 $\overline{\mathbf{X}}$ Japan (abstract) JP 11-221684 Aug. 17, 1999 Japan X (abstract) JP 11-267861 Oct. 5, 1999 Japan (abstract) JP 2000-015467 Jan. 18, 2000 Japan X (abstract) JP 2000-219528 Aug. 8, 2000 Japan X (abstract) JP 11-163403 Jun. 18, 1999 Japan X JP 11-177137 July 2, 1999 Japan X Japanese Patent Publication July 19, 1971 Japan X Kou-shou 46-24989 JP 06-252260 September 9, 1994 X Japan (abstract) JP 7-236985 September 12, 1995 Japan X (abstract) JP 10-202381 August 4, 1998 Japán X (abstract) JP 2001-093864 April 6, 2001 X Japan (abstract) June 24, 2004 PCT WO 2004/052586 A1 X (abstract) OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) K. Hayashi, "Inner Glass Marking by Harmonics of Solid-state Laser," Proceedings of 45th Laser Materials Processing Conference, Dec. 1998, pps. 23-28, with English abstract. T. Sano et al., "Evaluation of Processing Characteristics of Silicon With Picosecond Pulse Laser," Preprints of the National Meeting of Japan Welding Society, No. 66, April 2000, pp. 72-73, with English translation. K. Miura et al., "Formation of Photo-induced Structures in Glasses with Femtosecond Laser," Proceedings of 42nd Laser Materials Processing Conference, Nov. 1997, pp. 105-111, with English abstract. T. Miyazaki, "Laser Beam Machining Technology," published by Sangyo-Tosho Inc. on May 31, 1991, First Edition, pps. 9-10, with English translation. T. Yajima et al., New Version Laser Handbook, published by Asakura Shoten, June 15, 1989, pps. 666-669, with English translation. Tooling Machine Series, Laser Machining, published by Taiga Shuppan, Inc., Sept. 10, 1990, pps. 91-96, with English translation. Electronic Material, No. 9, on 2002, published by Kogyo Chousakai, pps. 17-21, with English translation. F. Fukuyo et al., "Stealth Dicing Technology for Ultra Thin Wafer", presented at 2003 ICEP (International Conference on Electronics Packaging), April 16-18, 2003, Tokyo, Japan Examiner Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.